

Notice of References Cited	Application/Control No. 10/751,436	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner CongVan Tran	Art Unit 2617	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,136,365 B2	11-2006	Nakatsugawa et al.	370/331
*	B	US-2002/0188562 A1	12-2002	Igarashi et al.	705/40
*	C	US-2001/0016492	08-2001	Igarashi et al.	455/433
*	D	US-2002/0006133	01-2002	Kakemizu et al.	370/401
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
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	S					
	T					

NON-PATENT DOCUMENTS

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	V	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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